



Sheet 1 of 1

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTORNEY DOCKET NO. 392.1680	APPLICATION NO. 09/546,214
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)		FIRST NAMED INVENTOR Atsushi WATANABE et al.	
		FILING DATE April 10, 2000	GROUP ART UNIT 2721 2621

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
VL	AA	5,845,048	12/01/98	Masumoto			

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO	
VL	AB	2 085 629	04/28/82	United Kingdom				

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)							TRANSLATION YES NO	
VL	AC	Ichiro Masaki, "Industrial Vision Systems Based on Application-Specific IC Chips", IEICE Transactions, Institute of Electronics, Vol. E74 No. 6, June 1, 1991, pages 1728-1734						
VL	AD	Michael Magee et al, "An Industrial Model Based Computer Vision System", Journal of Manufacturing Systems, Society of Manufacturing Engineers, Vol. 14 No. 3, 1995, pages 169-186						
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VL	AH	J. Homegger et al, "Statistical Learning, Localization, and Identification of Objects", IEEE, June 20, 1995, pages 914-919						
VL	AI	Juan Andrade-Cetto et al., Object Recognition, "Wiley Encyclopedia of Electrical Engineering", April 1, 2000, pages 449-470						

EXAMINER /Vu Le/	DATE CONSIDERED 04/28/2006
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	